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		Application/Control No.	Applicant(s)/Pa	atent Under
<u>. مغ</u>	Notice of References Cited	09/770,540	Reexamination SCHUEGARAF, KLAUS F.	
		Examiner	Art Unit	
		Laura M Schillinger	2813	Page 1 of 2

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
	Α	US-6060355	05-2000	Batra et al	438	255
	В	US-5760434	06-1998	Zahurak et al	257	307
	С	US-5770500	06-1998	Batra et al	438	255
	D	US-6090655	07-2000	Zahurak et al	438	239
	Ε	US-5563090	10-1996	Lee et al	437	60
	F	US-5366917	11-1994	Watanabe et al	437	47
	G	US-5413950	05-1995	Chen et al	437	52
	н	US-5861675	01-1999	Sasaki et al	257	764
	1	US-5245206	09-1993	Chu et al	257	309
	J	US-5384152	01-1995	Chu et al	427	81
	κ	US-5856237	01-1999	Ku	438	683
	L	US-5587614	12-19986	Hwang et al	257	532
	М	US-6107227	08-2000	Jacquin et al	501	138

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N						
	0			·			
	Р						
	a						
	R						
	s						
	Т						

## **NON-PATENT DOCUMENTS**

	NOW A CAN DOCUMENTO					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	٧					
	w					
	х					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

U.S. Patent and Trademark Office PTO-892 (Rev. 01-2001)

KRH 7-24-06

**Notice of References Cited** 

Part of Paper No. 4